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Chemistry-dependent magnetic properties at the FeNi oxide-metal interface Supplementary Information

F. Genuzio,^{1,2} T. O. Menteş,¹ K. Freindl,³ N. Spiridis,³ J. Korecki,^{3,4} and A. Locatelli¹

¹Elettra - Sincrotrone Trieste S.C.p.A., Basovizza, Trieste 34149, Italy

²Ceric-Eric, SS 14-km 163.5 in Area Science Park 34149 – Basovizza Trieste, Italy ³Jerzy Haber Institute of Catalysis and Surface Chemistry,

Polish Academy of Sciences, ul. Niezapominajek 8, 30-239 Kraków, Poland ⁴AGH University of Science and Technology, Faculty of Physics and Applied Computer Science,

> al. Mickiewicza 30, 30-259 Kraków, Poland (Dated: March 23, 2020)

I. OXIDATION OF Fe_{0.7}Ni_{0.3}

A. LEEM-IV characterization

Fig. 1 shows the electron reflectivity curves for the bcc and fcc regions as a function of O_2 exposure during the oxidation of the Fe_{0.7}Ni_{0.3} thin film. At the very early stages of oxidation (8.4 L dose) the reflectivity in the bcc region changes drammatically, whereas the changes in the fcc curve are less evident. At 18.6 L, both regions show entirely different LEEM IV curves as compared to the curves from the respective oxygen-free regions. Consistent with the LEED data, at 1240 L, both regions transform into a uniform FeO(111) layer, as evident from the easily recognizable LEEM IV fingerprint.^{1,2} At the oxygen dose of 1700 L an additional heterogeneity appears within both the fcc and bcc phases with slightly different IV curves. We attribute this to the onset of Fe₃O₄(111) island formation consistent with the weak (2 × 2) pattern observed in LEED.



FIG. 1: LEEM IV curves from the bcc and fcc regions of the phase separated Fe-Ni surface as a function of oxygen dose. At the highest dose shown (1700 L), surface appears heterogeneous at a length scale below 100 nm, and two distinct regions can be resolved both within the bcc and the fcc regions.



FIG. 2: XAS images and spectra from the Fe-Ni alloy film at the O K, Fe L and Ni L edges, after exposing the sample to 1250 L of oxygen. a) O K-edge XAS-PEEM, b) ratio between the images acquired at the "oxide" and "metal" peaks at the Fe L₃ edge, c) Ni L_3 -edge XAS-PEEM. d) O Kedge, e) Fe L- edge, f) Ni L- edge XAS spectra are shown on the right column.

B. Reactivity of the fcc-bcc phase boundary

Fig. 2 shows the spatially resolved XAS measurements at the O K (Fig. 2a,d), Fe $L_{2,3}$ (Fig. 2b,e) and Ni $L_{2,3}$ (Fig. 2c,f) edges after exposure to 1250 L of O₂. The fcc-bcc phase boundary has a different chemical contrast in laterally resolved images, arising from the higher amount of oxygen and oxidized Fe at the border, as compared to the rest of the surface. The specific features in both XAS spectra indicate the formation of Fe₃O₄ at the fcc-bcc phase boundary well before the rest of the surface.

II. Fe₃O₄/bcc(FeNi) FERROMAGNETIC COUPLING

The coupling between the Fe₃O₄ and bcc(110) Fe-Ni film underneath is not easy to determine using XMCD-PEEM, due to the small irregular magnetic domains. Nevertheless, a careful analysis of the XMCD contrast as a function of photon energy at the Fe L₃ edge (in Fig. 3) reveals the general tendency. In all three panels, the horizontally-elongated region on the top of the images correspond to a dewetted area with no magnetic contrast. Fig. 3a, taken at a photon energy (708.0 eV) at the metallic Fe peak as well as the Fe²⁺ O_h peak of Fe₃O₄, shows dark contrast in most of the bcc region. In Fig. 3b, which is taken at 709.1 eV at the Fe³⁺ T_h peak, the XMCD nearly disappears. In Fig. 3c at the Fe³⁺ O_h peak, the dark contrast reappears. In short, the XMCD signal in Fig. 3a and Fig. 3c has the same sign, which is an indication that the magnetization within the metallic alloy underneath is aligned in the same direction as the majority axis of the oxide above.



FIG. 3: XMCD images at the Fe L_3 -edge for a phase separated Fe_{0.70}Ni_{0.30} film exposed to 1750 L of molecular oxygen.

III. OXIDATION OF Fe_{0.5}Ni_{0.5} THIN FILM AND MAGNETIC PROPERTIES

A homogeneous thin film having the same structure (fcc) and stoichiometry (Fe_{0.5}Ni_{0.5}) was prepared to mimic the oxidation of the fcc crystallites. We oxidized the sample (T = 200-250 °C; 1×10^{-6} mbar O₂) stepwise, consistently to what was done for the Fe_{0.7}Ni_{0.3} thin film. These measurements confirm the general trend found for the mixed bcc-fcc case; the higher Ni concentration the slower the oxidation. In particular, we find that the exposure of 3000 L is not sufficient to form a superficial Fe₃O₄. The outcomes of the spectroscopic and structural data are contradictory with each other, and do not allow the assessment of the superficial oxide phase. On one hand, the LEED of the surface (Fig. 5c) shows a (1x1) reconstruction typical for FeO(111) (Fig. 4b), on the other, the XAS (Fig. 4d) and CEMS measurements (see Table I and Fig. 4) suggest the presence of an oxide with higher oxidation level. The low B_{hf} value for such non-specific oxide components in the CEMS spectrum points toward a non-ferromagnetic phase. More than half of the Fe remains in the metallic state. We note that the exposure to 10500 L was necessary to observe a weak (2x2) reconstruction in LEED (see for instance Figure 4c).



FIG. 4: On the left, LEED pattern of the $\text{Fe}_{0.5}\text{Ni}_{0.5}$ film as prepared (a) and after exposure to 3000 L (b) and 10500 L (c) ($\text{E}_k = 45\text{eV}$); the red hexagon indicates the positions of the FeO(111) main diffraction spots. d) corresponding XAS spectra at the Fe $L_{2,3}$ edge for samples exposed to the same O₂ dose.

	$ ext{IS} ext{[mm/s]}$	$\langle B_{hf} \rangle$ [T]	Relative Intensity $\%$	
metallic	0.04	29.6	53.8	
Non-specific oxide	0.35	9.5	46.3	

TABLE I: Mössbauer hyperfine parameters of the $Fe_{0.50}Ni_{0.50}$ film after exposure to 3750 L O₂ at 250°C, with an intermediate annealing step to 350°C after 750 L dose.

The variation of the XPS core level intensity ration $(I_{Fe}^{XPS}/I_{Ni}^{XPS})$ (Figure 6) and XAS (Figure 4d) measurement demonstrate that the oxidation causes the segregation of Fe the surface of the film. Based on both the XPS and the CEMS measurements, we find that the amount of Fe segregated to the surface layer and the degree of oxidation are lower in the homogeneous Fe_{0.5}Ni_{0.5} film when compared to that of the fcc islands having the same stoichiometry and structure.



FIG. 5: CEMS spectrum of the $Fe_{0.5}Ni_{0.5}$ film after exposure 3750 L O₂. The spectral components are color-coded: light gray – metallic FeNi, blue – non-specific oxide component.

The magnetic coupling between the top most oxide and the metallic layer was investigated using XMCD-PEEM at each oxidation step. At both oxidation stages (3000 L and 10500 L O₂ exposure) we find FM coupling between Fe and Ni in the alloy, along the W(1-10) direction, as demonstrated by the XMCD-images a and c in Figure 7 at the Fe^{met} and Ni^{met} peaks. In the XMCD-Images acquired at the Fe^{oxide} there is no magnetic contrast (images b and d in Figure 7), demonstrating that the oxide layer is not magnetic.

¹ M. Monti, B. Santos, A. Mascaraque, O. Rodríguez de la Fuente, M. A. Niño, T. O. Menteş, A. Locatelli, K. F. McCarty, J. F. Marco, and J. de la Figuera, The Journal of Physical Chemistry C **116**, 11539 (2012).

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FIG. 6: Comparison of the Evolution of the Fe 3p and Ni 3p core level intensity ration as function of O₂ exposure between the crystallite and their thin-film counterpart. The plot shows that Fe surface segregation is smaller in the thin film case, leading to a thinner surface Fe-oxide layer. (hv = 250 eV).



FIG. 7: XMCD-PEEM images at the Fe L_3 - edge (metal and oxide components) and Ni L_3 - edge for the Fe_{0.5}Ni_{0.5} thin film after 3000 L (a,b) and 10500 (c,d) O₂ exposure. The FM coupling of the FeNi layer is evident from the superposition of the corresponding XMCD images. The oxide layer does not show any magnetic contrast. The incoming photon beam directions, oriented as the [110]_W crystalline axes of the substrate is shown in the Fig. 7b as an arrow.